2SD2575

Silicon NPN epitaxial planar type

For low-frequency power amplification

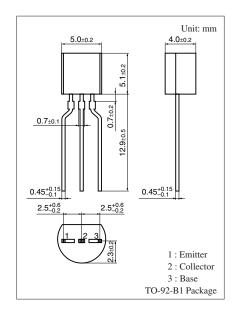
■ Features

 \bullet Low collector-emitter saturation voltage $V_{\text{CE}(\text{sat})}$

■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	V _{CBO}	15	V	
Collector-emitter voltage (Base open)	V _{CEO}	10	V	
Emitter-base voltage (Collector open)	V_{EBO}	10	V	
Collector current	I_{C}	5	A	
Peak collector current *	I_{CP}	9	A	
Collector power dissipation	P _C	750	mW	
Junction temperature	T_j	150	°C	
Storage temperature	T _{stg}	-55 to +150	°C	



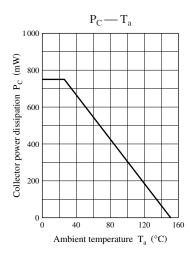


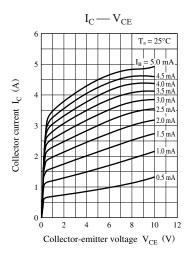
■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

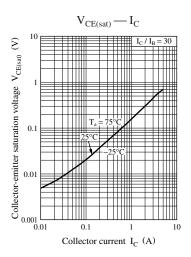
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_C = 1 \text{ mA}, I_E = 0$	10			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = 10 \mu\text{A}, I_B = 0$	10			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = 10 \text{ V}, I_{E} = 0$			0.1	μΑ
Collector-emitter cutoff current (Base open)	I _{CEO}	$V_{CE} = 5 \text{ V}, I_{B} = 0$			1.0	μΑ
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = 5 \text{ V}, I_{E} = 0$			0.1	μΑ
Forward current transfer ratio *	h _{FE1}	$V_{CE} = 2 \text{ V}, I_{C} = 0.5 \text{ A}$	700			_
	h _{FE2}	$V_{CE} = 2 \text{ V}, I_{C} = 2 \text{ A}$	195			
Collector-emitter saturation voltage *	V _{CE(sat)}	$I_C = 3 \text{ A}, I_B = 0.1 \text{ A}$		0.28	0.50	V
Transition frequency	f_T	$V_{CB} = 6 \text{ V}, I_{E} = -50 \text{ mA}, f = 200 \text{ MHz}$		170		MHz
Collector output capacitance	C _{ob}	$V_{CB} = 20 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		45	65	pF
(Common base, input open circuited)						

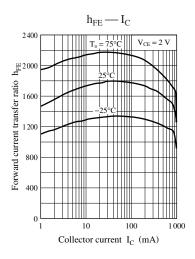
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

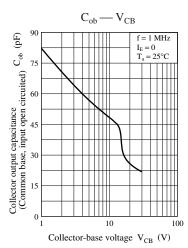
^{2. *:} Pulse measurement











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